

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/081,441	<b>Applicant(s)/Patent under Reexamination</b> LEE, SHIH-JONG J.
	<b>Examiner</b> Joseph P. Hirl	<b>Art Unit</b> 2129

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner